

DM74ALS37A

Quadruple 2-Input NAND Buffer

General Description

This device contains four independent gates, each of which performs the logic NAND function.

Features

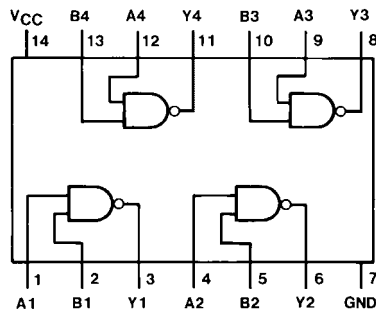
- Switching specifications at 50 pF
- Switching specifications guaranteed over full temperature and V_{CC} range
- Advanced oxide-isolated, ion-implanted Schottky TTL process
- Functionally and pin for pin compatible with LS TTL counterpart
- Improved AC performance over LS37
- Improved line receiving characteristics

Ordering Code:

Order Number	Package Number	Package Description
DM74ALS37AM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
DM74ALS37AN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Function Table

$$Y = \overline{AB}$$

Inputs		Output
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

H = HIGH Logic Level
L = LOW Logic Level

DM74ALS37A Quadruple 2-Input NAND Buffer

Absolute Maximum Ratings(Note 1)

Supply Voltage	7V
Input Voltage	7V
Operating Free Air Temperature Range	0°C to +70°C
Storage Temperature Range	–65°C to +150°C
Typical θ_{JA}	
N Package	83.0°C/W
M Package	114.0°C/W

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Recommended Operating Conditions

Symbol	Parameter	Min	Nom	Max	Units
V_{CC}	Supply Voltage	4.5	5	5.5	V
V_{IH}	HIGH Level Input Voltage	2			V
V_{IL}	LOW Level Input Voltage			0.8	V
I_{OH}	HIGH Level Output Current			–2.6	mA
I_{OL}	LOW Level Output Current			24	mA
T_A	Free Air Operating Temperature	0		70	°C

Electrical Characteristics

over recommended operating free air temperature range. All typical values are measured at $V_{CC} = 5V$, $T_A = 25^\circ C$.

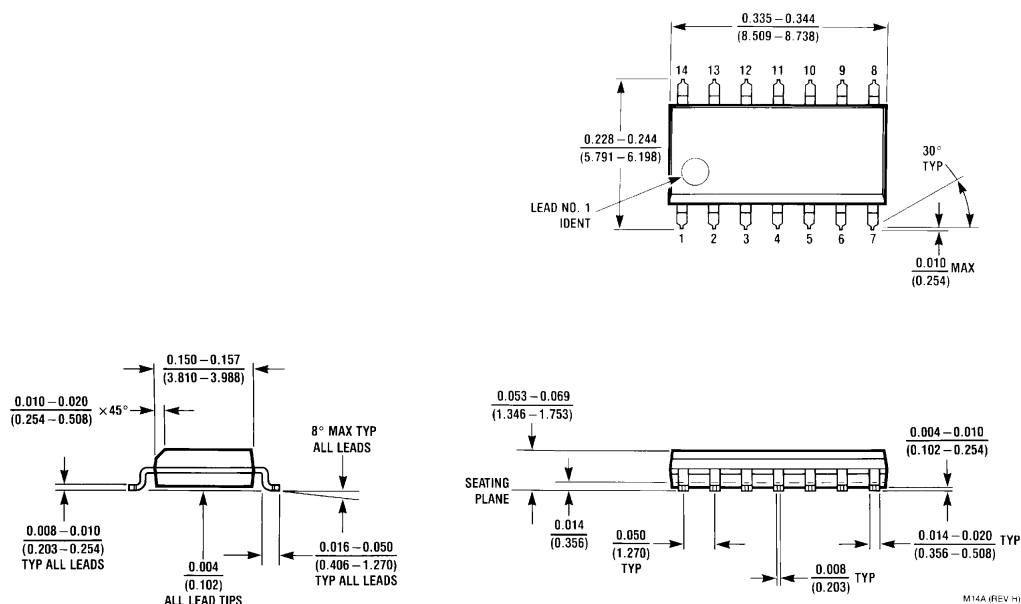
Symbol	Parameter	Conditions	Min	Typ	Max	Units
V_{IK}	Input Clamp Voltage	$V_{CC} = 4.5V$, $I_I = -18\text{ mA}$			–1.5	V
V_{OH}	HIGH Level Output Voltage	$V_{CC} = 4.5V$	$I_{OH} = -2.6\text{ mA}$	2.4	3.3	V
		$V_{IL} = \text{Max}$				V
		$I_{OH} = -400\text{ }\mu A$				V
V_{OL}	LOW Level Output Voltage	$V_{CC} = 4.5V$	$I_{OL} = 12\text{ mA}$	0.25	0.4	V
		$V_{IH} = 2V$	$I_{OL} = 24\text{ mA}$	0.35	0.5	V
						V
I_I	Input Current @ Maximum Input Voltage	$V_{CC} = 5.5V$, $V_{IH} = 7V$			0.1	mA
I_{IH}	HIGH Level Input Current	$V_{CC} = 5.5V$, $V_{IH} = 2.7V$			20	μA
I_{IL}	LOW Level Input Current	$V_{CC} = 5.5V$, $V_{IL} = 0.4V$			–0.1	mA
I_O	Output Drive Current	$V_{CC} = 5.5V$	$V_O = 2.25V$	–30	–112	mA
I_{CCH}	Supply Current with Outputs HIGH	$V_{CC} = 5.5V$, $V_I = 0V$		0.86	1.6	mA
I_{CCL}	Supply Current with Outputs LOW	$V_{CC} = 5.5V$, $V_I = 4.5V$		4.0	7.8	mA

Switching Characteristics

over recommended operating free air temperature range

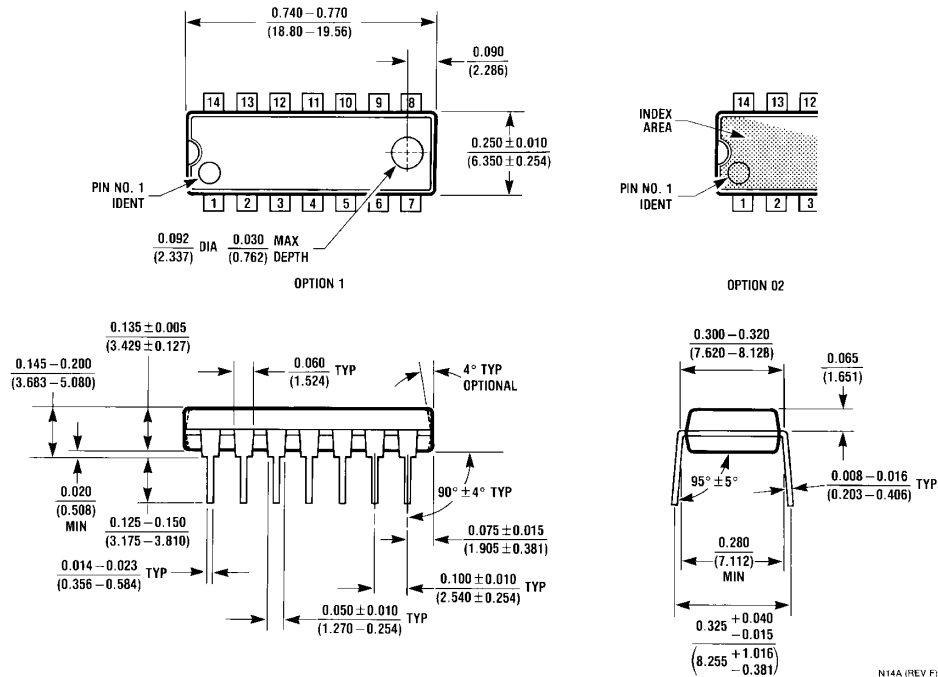
Symbol	Parameter	Conditions	Min	Max	Units
t_{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	$V_{CC} = 4.5V$ to $5.5V$ $R_L = 500\Omega$ $C_L = 50\text{ pF}$	2	8	ns
t_{PHL}	Propagation Delay Time HIGH-to-LOW Level Output		2	7	ns

Physical Dimensions inches (millimeters) unless otherwise noted



**14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
Package Number M14A**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



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